Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,222	LI, JIN	
Examiner	Art Unit	
Joseph Nauven	2815	

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Class	Subclass	Date	Examiner
257	294, 440	6/6/2006	JN
257	431, 432	6/6/2006	NL
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